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Substitute for form 1449A/B/PTO				Complete if Known		
				Application Number	09/646,680; Conf. # 5089	
IN	NFORMATIO	N DIS	CLOSURE	Filing Date	November 4, 2000	
STATEMENT BY APPLICANT			PPLICANT	First Named Inventor	Hideo Yamanaka et al.	
				Art Unit	1762	
	(Use as many sheets as necessary)			Examiner Name	E. B. Fuller	
Sheet	1	of	1	Attorney Docket Number	SON-1782/KOI	

			U.S. PA	TENT DOCUMENTS		
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Whei Relevant Passages or Releva Figures Appear	
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	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			Where Relevant Passages or Relevant Figures Appear	

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NON PATENT LITERATURE DOCUMENTS					
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